

## OptiMOS®-T2 Power-Transistor





#### **Features**

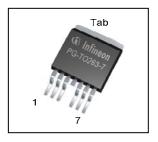
- N-channel Enhancement mode
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested
- Ultra low R<sub>DSon</sub>
- Ultra high  $I_D$

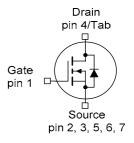
Туре	Package	Marking
IPB180N06S4-H1	PG-TO263-7-3	4N06H1

## **Product Summary**

V <sub>DS</sub>	60	V
R <sub>DS(on),max</sub>	1.7	mΩ
I <sub>D</sub>	180	Α

#### PG-TO263-7-3





## **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	T <sub>C</sub> =25°C, V <sub>GS</sub> =10V	180	Α
		$T_{\rm C}$ =100°C, $V_{\rm GS}$ =10 $V^{2)}$	180	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25°C	720	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	/ <sub>D</sub> =90A	700	mJ
Avalanche current, single pulse	IAS	-	180	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> =25°C	250	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	0.60	K/W
SMD version, device on PCB	$R_{\mathrm{thJA}}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	

## **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

#### **Static characteristics**

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> = 1mA	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 200 \mu {\rm A}$	2.0	3.0	4.0	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C	-	0.03	1	μΑ
		$V_{\rm DS}$ =60V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C <sup>2)</sup>	-	10	200	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =100A	-	1.3	1.7	mΩ



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	C iss		-	16840	21900	pF
Output capacitance	C <sub>oss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	-	4120	5360	
Reverse transfer capacitance	C <sub>rss</sub>		-	160	320	
Turn-on delay time	t <sub>d(on)</sub>		-	30	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V,	-	5	-	
Turn-off delay time	$t_{\text{d(off)}}$	$I_{\rm D}$ =180A, $R_{\rm G}$ =3.5 $\Omega$	-	60	-	
Fall time	t <sub>f</sub>		-	15	-	
Gate Charge Characteristics <sup>2)</sup>	_		1	ī	ı	
Gate to source charge	Q <sub>gs</sub>		-	84	110	nC
Gate to drain charge	Q <sub>gd</sub>	$V_{\rm DD}$ =48V, $I_{\rm D}$ =180A, $V_{\rm GS}$ =0 to 10V	-	22.5	45	
Gate charge total	Q <sub>g</sub>		-	208	270	
Gate plateau voltage	$V_{ m plateau}$		-	5.0	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T -25°C	-	-	180	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	- T <sub>C</sub> =25°C	-	-	720	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =100A, T <sub>j</sub> =25°C	0.6	0.95	1.3	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	$V_R$ =30V, $I_F$ =180A, d $i_F$ /d $t$ =100A/ $\mu$ s	-	60	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>		-	90	-	nC

 $<sup>\</sup>overline{}^{(1)}$  Current is limited by bondwire; with an  $R_{\text{thJC}}$  = 0.6K/W the chip is able to carry 299A at 25°C.

<sup>&</sup>lt;sup>2)</sup> Specified by design. Not subject to production test.

 $<sup>^{3)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



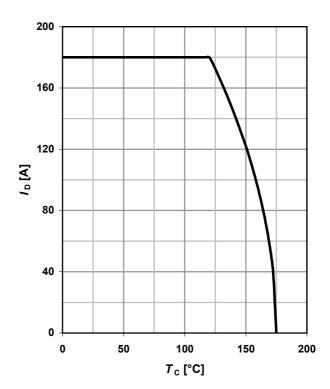
#### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

# 250 200 200 150 100 50 100 100 150 200 T<sub>C</sub> [°C]

#### 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}; \text{SMD}$$



## 3 Safe operating area

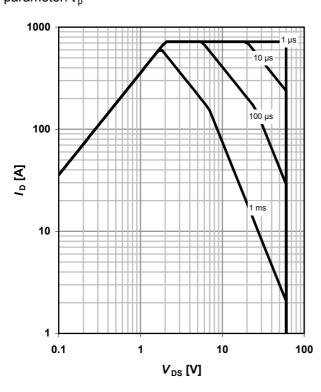
$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}\text{C}; D = 0; \text{SMD}$$

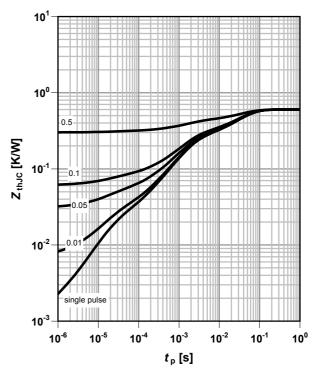
parameter:  $t_p$ 

#### 4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter:  $D = t_p/T$ 



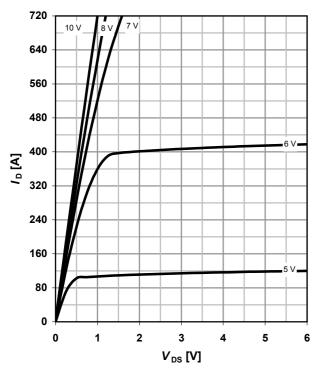




## 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C; SMD$ 

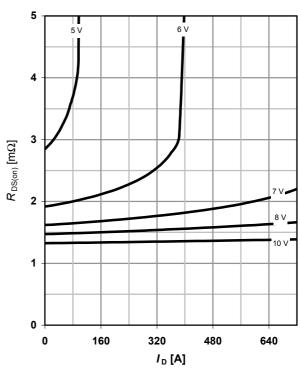
parameter:  $V_{\rm GS}$ 



#### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}; SMD$ 

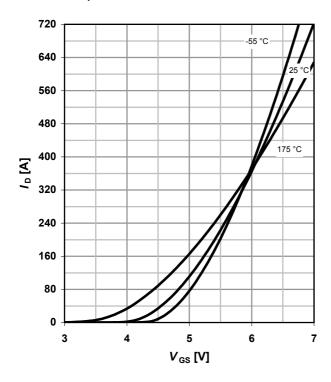
parameter: V<sub>GS</sub>



## 7 Typ. transfer characteristics

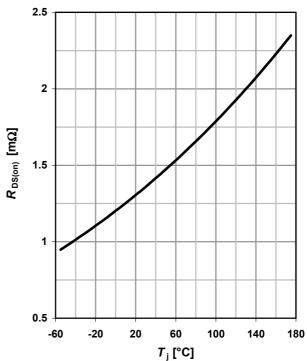
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter: T<sub>i</sub>



#### 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}; \text{SMD}$$





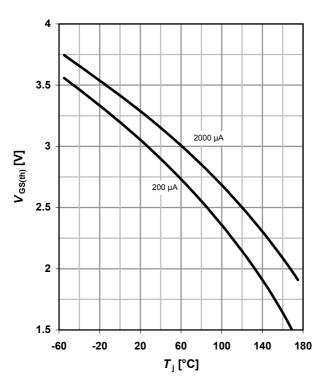
## 9 Typ. gate threshold voltage

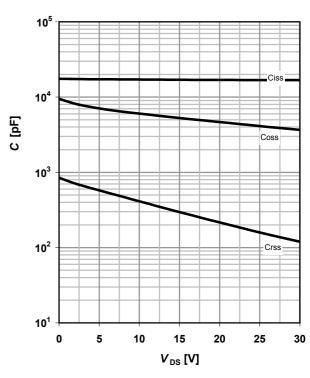
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

#### 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 

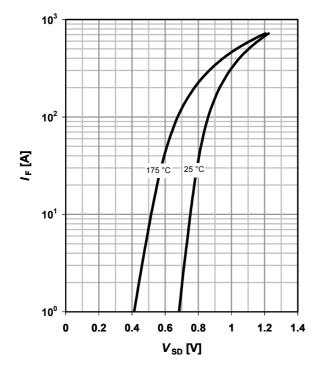




## 11 Typical forward diode characteristicis

 $IF = f(V_{SD})$ 

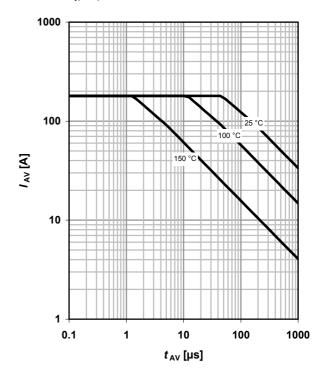
parameter: T<sub>i</sub>



#### 12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter:  $T_{j(start)}$ 



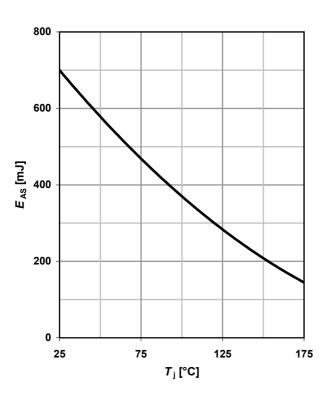


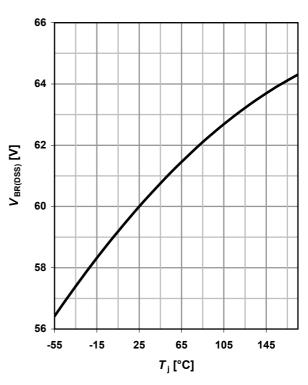
#### 13 Avalanche energy

$$E_{AS} = f(T_i); I_D = 90 A$$

## 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

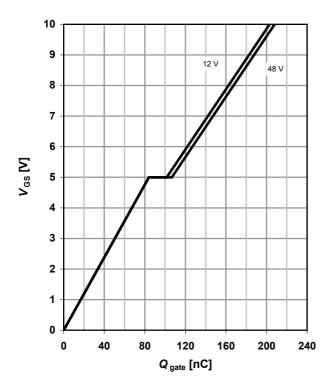




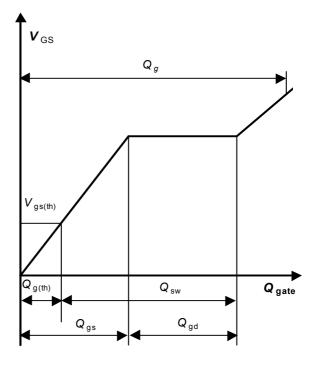
## 15 Typ. gate charge

 $V_{\rm GS}$  = f(Q  $_{\rm gate}$ );  $I_{\rm D}$  = 180 A pulsed

parameter:  $V_{\rm DD}$ 



## 16 Gate charge waveforms





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Revision History

Version	Date	Changes		
Revision 1.0	25.03.2009	Final data sheet		